



US00D401874S

# United States Patent [19]

Arnoux et al.

[11] **Patent Number: Des. 401,874**

[45] **Date of Patent: \*\*Dec. 1, 1998**

[54] **CLAMP-ON CURRENT PROBE**

4,518,913 5/1985 Jackson ..... 324/127

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[73] Assignee: **Societe Chauvin Arnoux**, Paris, France

[57] **CLAIM**

[\*\*] Term: **14 Years**

The ornamental design for a clamp-on current probe, as shown.

[21] Appl. No.: **61,105**

**DESCRIPTION**

[22] Filed: **Oct. 16, 1996**

FIG. 1 is a perspective view of the clamp-on current probe according to our new design;

[51] **LOC (6) Cl. .... 10-04**

FIG. 2 is a front elevational view thereof;

[52] **U.S. Cl. .... D10/78**

FIG. 3 is a rear elevational view thereof;

[58] **Field of Search ..... D10/79; 324/126, 324/127; 336/175, 212**

FIG. 4 is a top plan view thereof;

FIG. 5 is a bottom plan view thereof;

[56] **References Cited**

FIG. 6 is a left side elevational view thereof, as seen from the left side of FIG. 2; and,

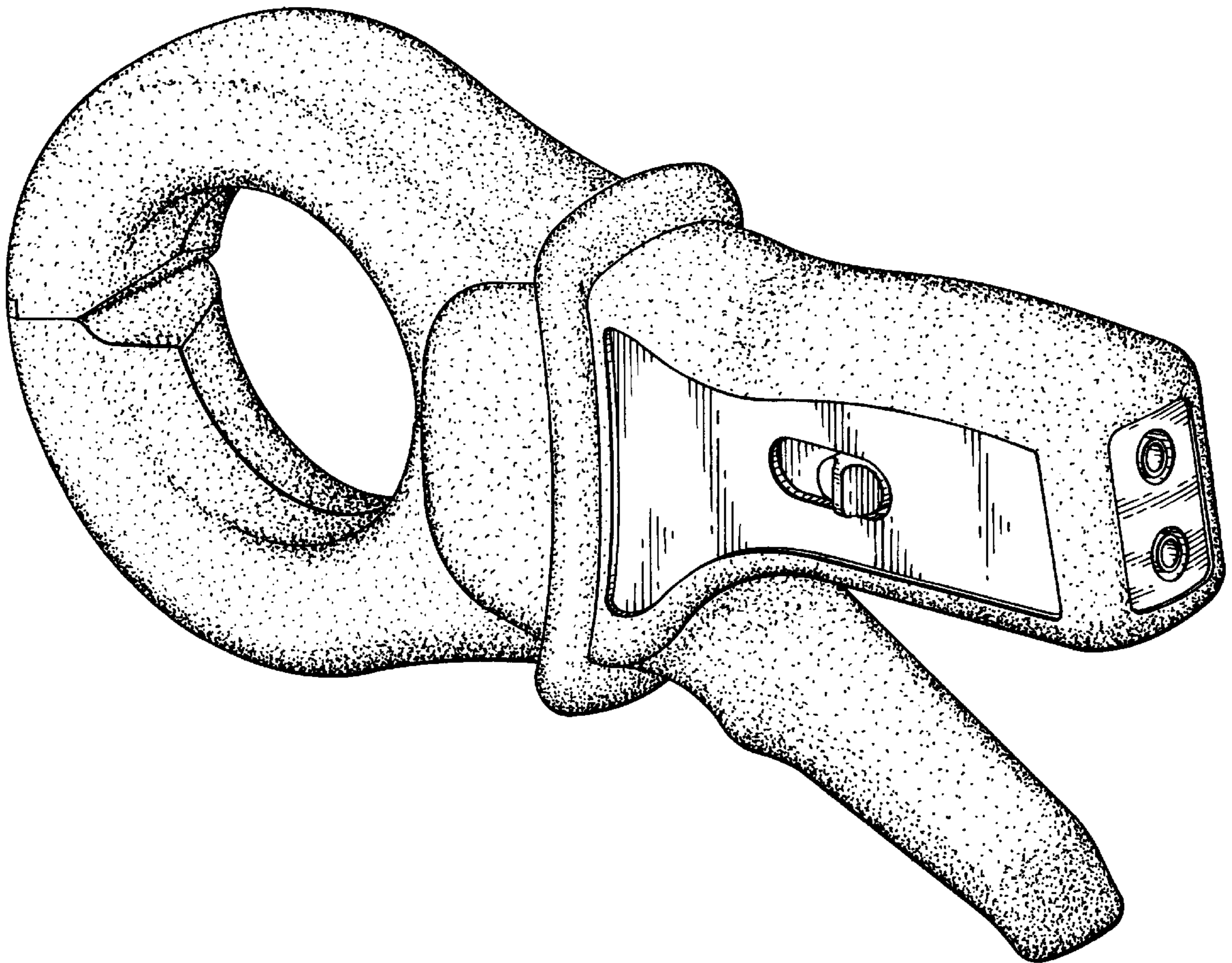
FIG. 7 is a right side elevational view thereof.

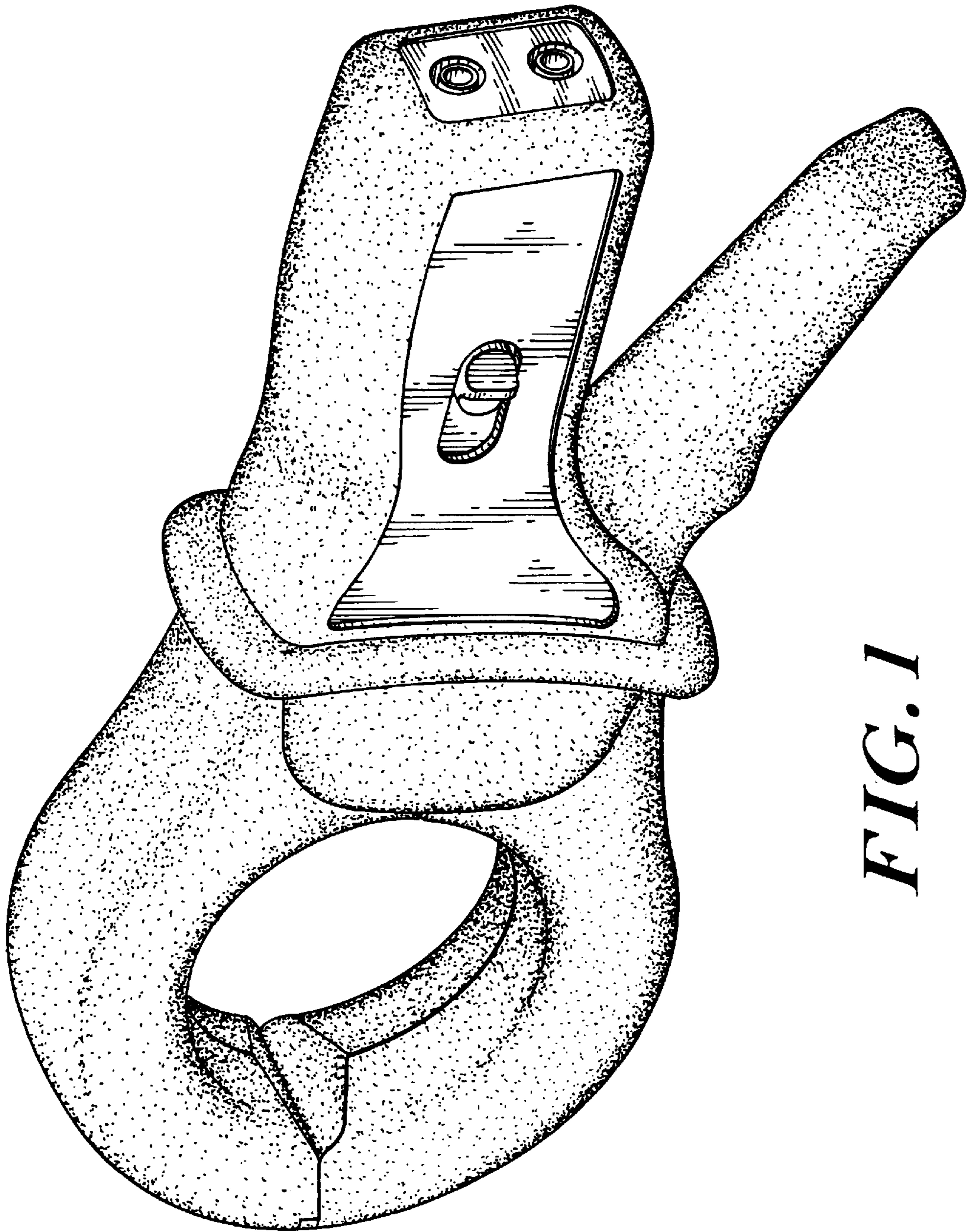
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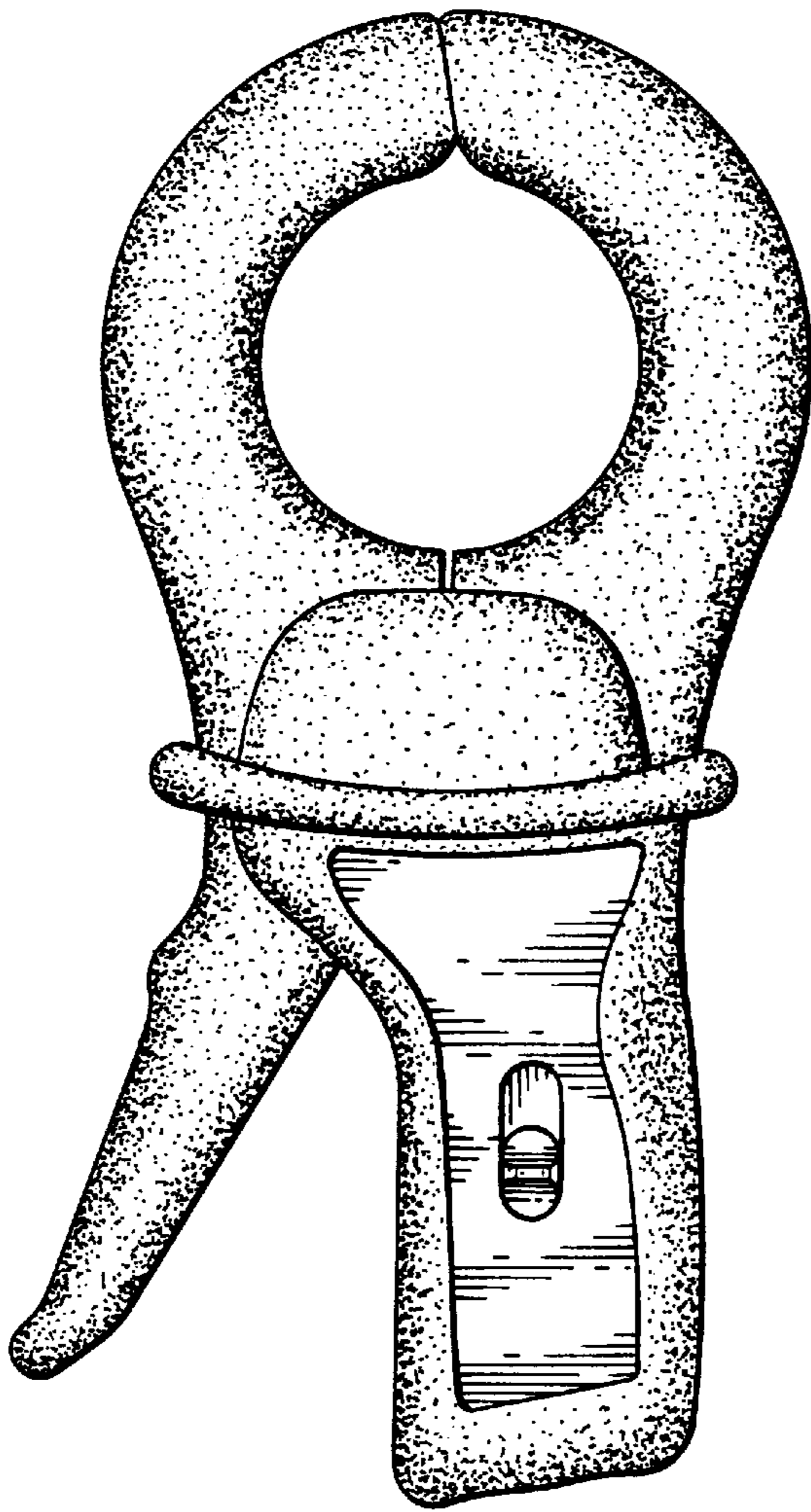
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**1 Claim, 4 Drawing Sheets**

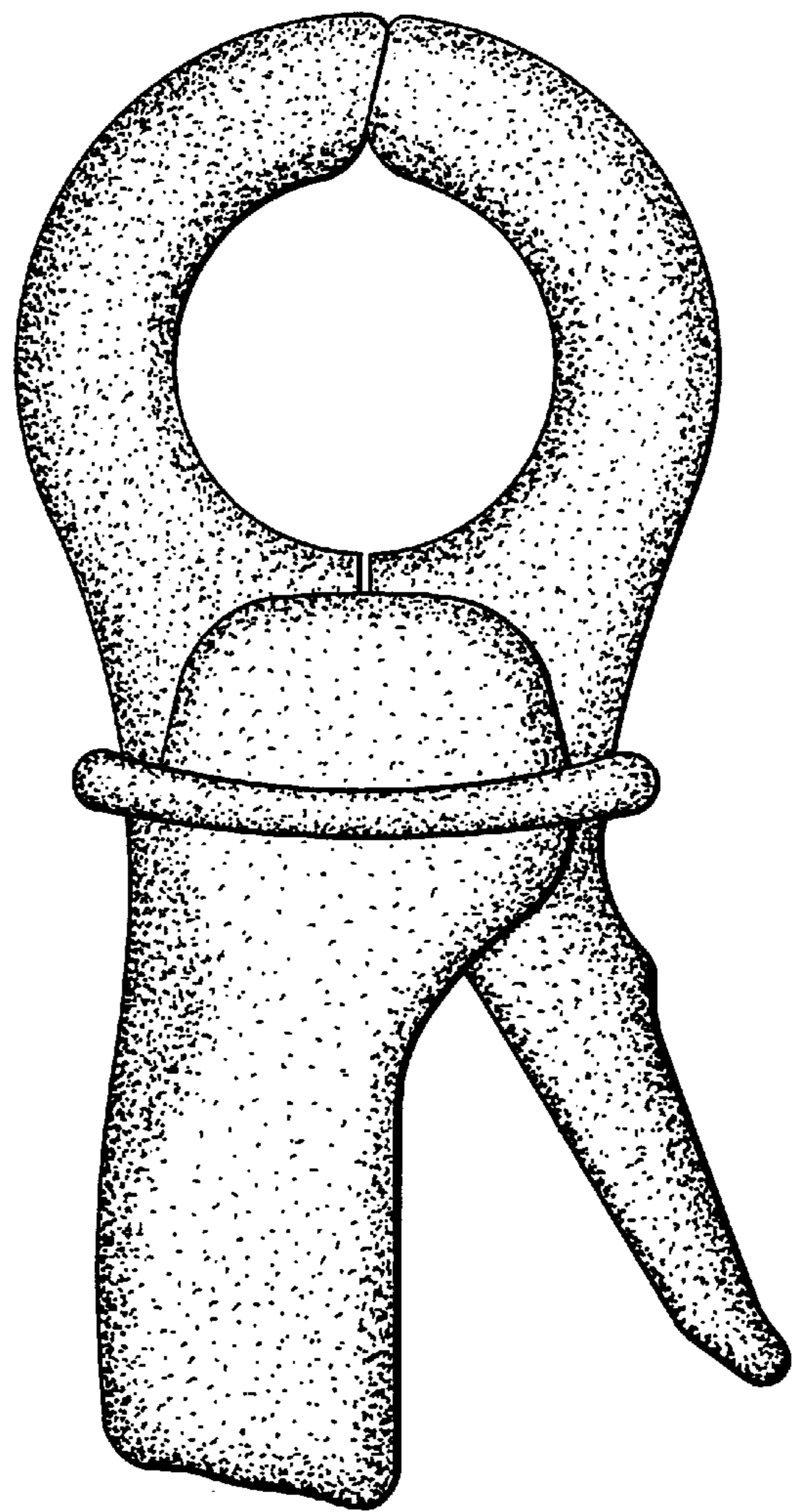




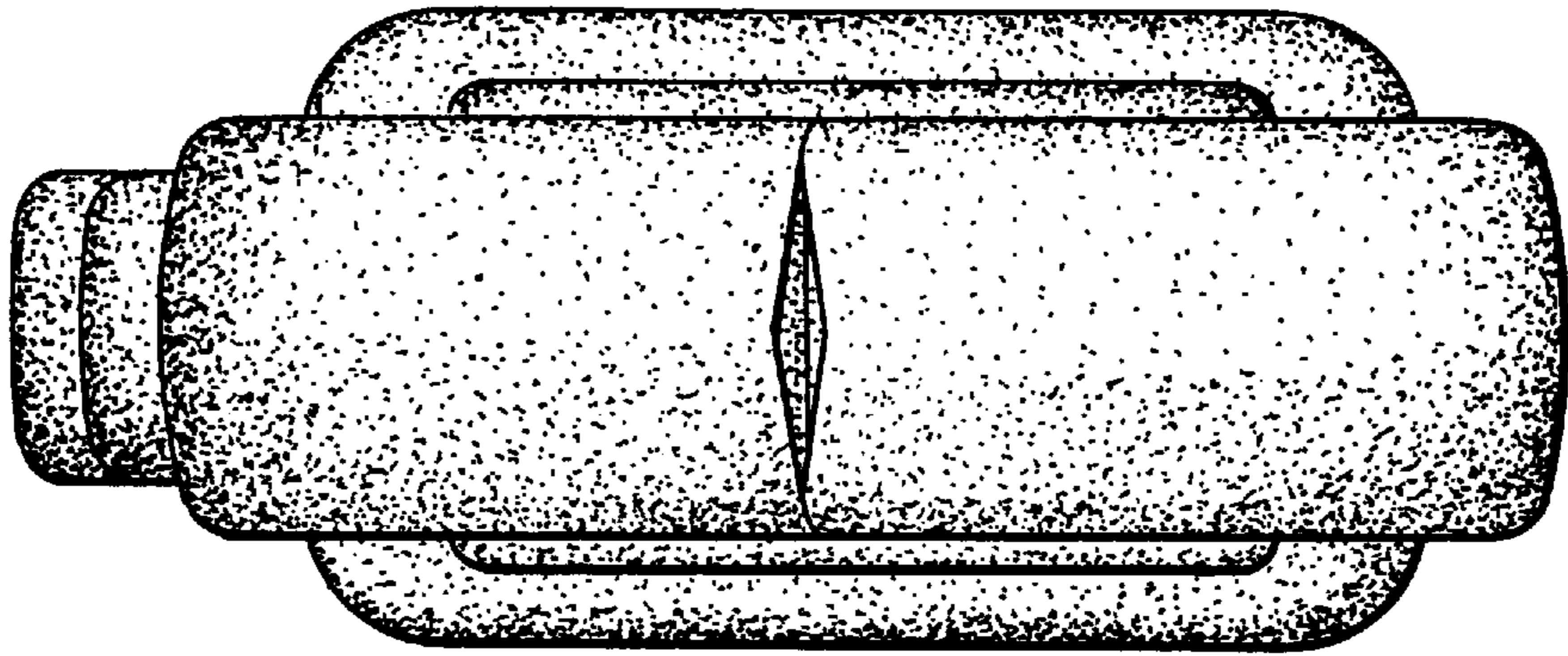
*FIG. 1*



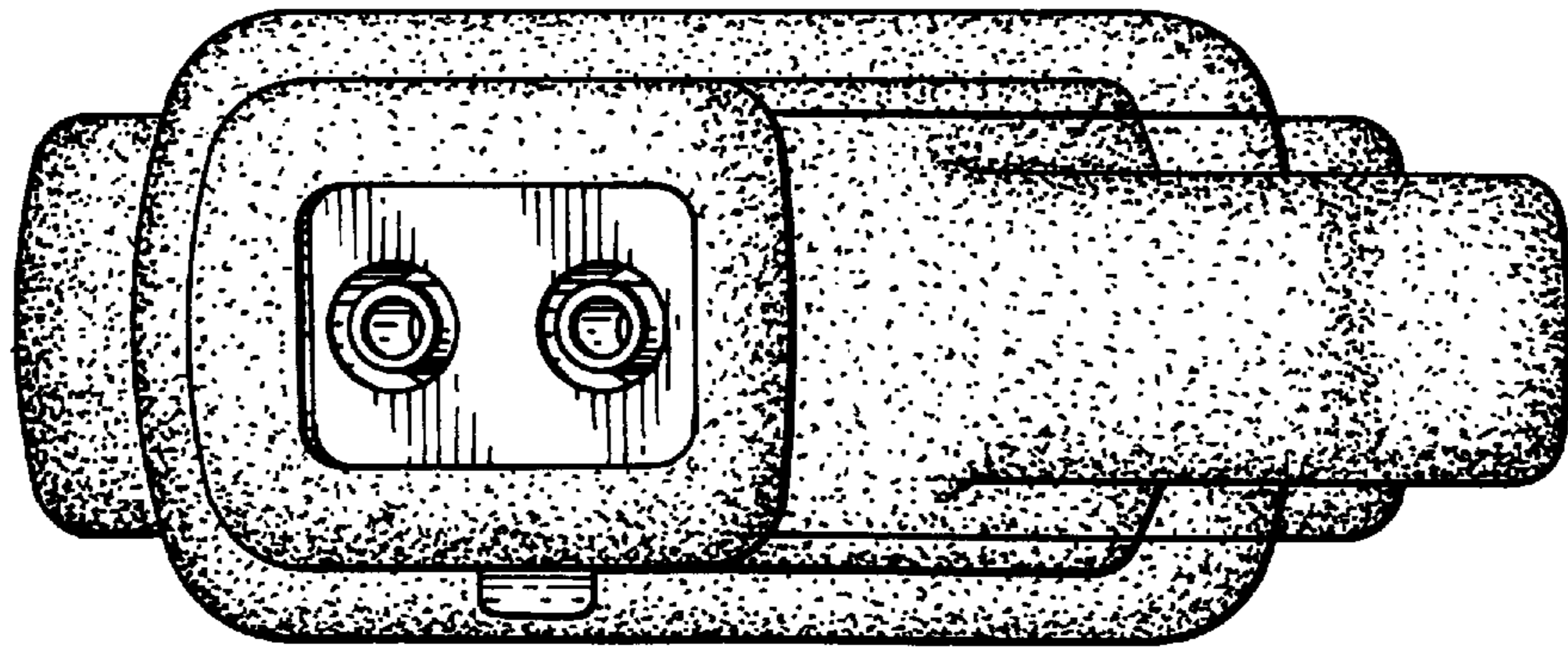
***FIG. 2***



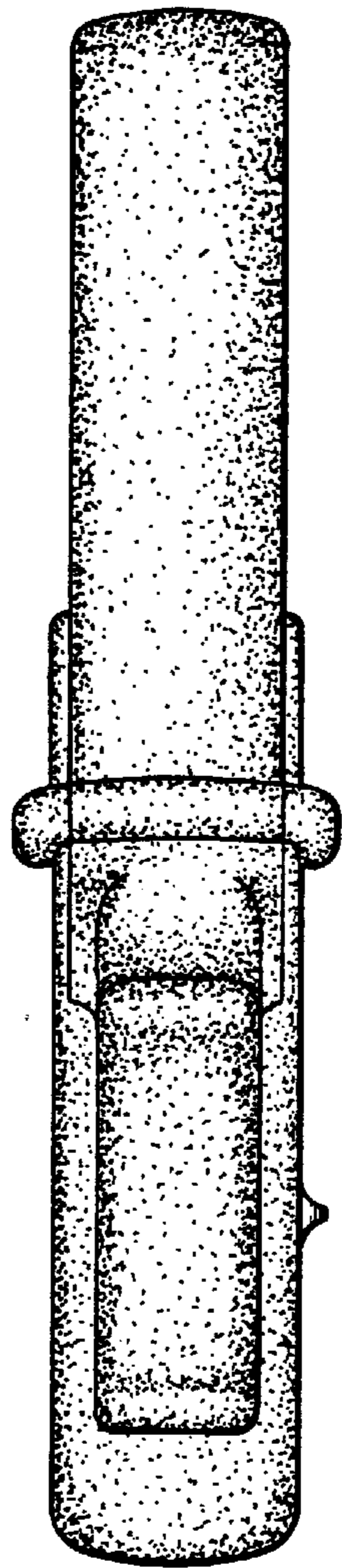
***FIG. 3***



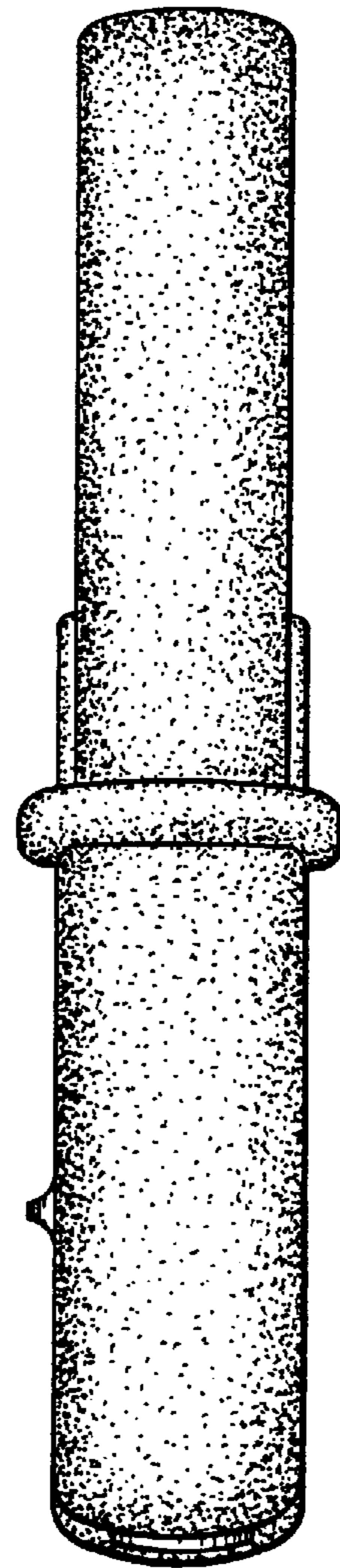
*FIG. 4*



*FIG. 5*



*FIG. 6*



*FIG. 7*